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APPLICATION NO. FILING DATE		FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.	
10/721.847 11/25/2003		11/25/2003	Satchidanand Mishra	A 11451	6934	
25453	7590	09/05/2006		EXAM	EXAMINER	
		ENTATION CENT	THOMAS, LUCY M			
XEROX CO		HON , SOUTH, XEROX S	ART UNIT	PAPER NUMBER		
ROCHESTER, NY 14644				2836		
				DATE MAILED: 09/05/2006		

Please find below and/or attached an Office communication concerning this application or proceeding.

## Advisory Action Before the Filing of an Appeal Brief

Application No.	Applicant(s)		
10/721,847	MISHRA ET AL.		
Examiner	Art Unit		
Lucy Thomas	2836		

	Lucy Thomas	2836	
The MAILING DATE of this communication appe	ars on the cover sheet with the o	orrespondence add	ress
THE REPLY FILED 17 August 2006 FAILS TO PLACE THIS AF	PPLICATION IN CONDITION FOR	ALLOWANCE.	
1.  The reply was filed after a final rejection, but prior to or on this application, applicant must timely file one of the follow places the application in condition for allowance; (2) a No a Request for Continued Examination (RCE) in compliance time periods:	ving replies: (1) an amendment, aff tice of Appeal (with appeal fee) in the with 37 CFR 1.114. The reply m	fidavit, or other evider compliance with 37 C	nce, which FR 41.31; or (3)
a) The period for reply expires <u>3</u> months from the mailing date	-		
b) The period for reply expires on: (1) the mailing date of this A no event, however, will the statutory period for reply expire is Examiner Note: If box 1 is checked, check either box (a) or (	ater than SIX MONTHS from the mailin	g date of the final rejecti	on.
TWO MONTHS OF THE FINAL REJECTION. See MPEP 70	06.07(f).		
Extensions of time may be obtained under 37 CFR 1.136(a). The date have been filed is the date for purposes of determining the period of ex under 37 CFR 1.17(a) is calculated from: (1) the expiration date of the set forth in (b) above, if checked. Any reply received by the Office later may reduce any earned patent term adjustment. See 37 CFR 1.704(b)	tension and the corresponding amount shortened statutory period for reply orig than three months after the mailing da	of the fee. The appropr inally set in the final Offi	iate extension fee ice action; or (2) as
<ul> <li>NOTICE OF APPEAL</li> <li>The Notice of Appeal was filed on A brief in compfiling the Notice of Appeal (37 CFR 41.37(a)), or any external Notice of Appeal has been filed, any reply must be filed</li> </ul>	nsion thereof (37 CFR 41.37(e)), to	avoid dismissal of th	
<u>AMENDMENTS</u>	•	.,	
<ol> <li>The proposed amendment(s) filed after a final rejection,</li> <li>(a) They raise new issues that would require further co</li> <li>(b) They raise the issue of new matter (see NOTE belo</li> <li>(c) They are not deemed to place the application in below the second s</li></ol>	nsideration and/or search (see NO w);	TE below);	
appeal; and/or (d) They present additional claims without canceling a	corresponding number of finally rej		
NOTE: (See 37 CFR 1.116 and 41.33(a)).			
4. The amendments are not in compliance with 37 CFR 1.1.		empliant Amendment	(PTOL-324).
5. Applicant's reply has overcome the following rejection(s)		times to file de amondos	
<ol> <li>Newly proposed or amended claim(s) would be al non-allowable claim(s).</li> </ol>	lowable if submitted in a separate,	umely filed amendme	ent canceling the
7.  For purposes of appeal, the proposed amendment(s): a) how the new or amended claims would be rejected is protected. The status of the claim(s) is (or will be) as follows: Claim(s) allowed:		If be entered and an e	explanation of
Claim(s) objected to: <u>4</u> . Claim(s) rejected: 1-3 and 5-23.			
Claim(s) withdrawn from consideration:			
AFFIDAVIT OR OTHER EVIDENCE			
<ol> <li>The affidavit or other evidence filed after a final action, but because applicant failed to provide a showing of good an was not earlier presented. See 37 CFR 1.116(e).</li> </ol>			
9. The affidavit or other evidence filed after the date of filing entered because the affidavit or other evidence failed to of showing a good and sufficient reasons why it is necessar	overcome <u>all</u> rejections under appe y and was not earlier presented. S	al and/or appellant fa see 37 CFR 41.33(d)(	ils to provide a 1).
10. The affidavit or other evidence is entered. An explanatio REQUEST FOR RECONSIDERATION/OTHER	n of the status of the claims after e	ntry is below or attacl	hed.
<ul> <li>11.  The request for reconsideration has been considered bu <u>See Continuation Sheet.</u></li> </ul>	t does NOT place the application i	n condition for allowa	nce because:
<ul><li>12. ☐ Note the attached Information Disclosure Statement(s).</li><li>13. ☐ Other:</li></ul>	(PTO/SB/08 or PTO-1449) Paper N	Vo(s).	
•			
		RIAN SIRCUS	
	CLIDERVISO	IRY PATENT EXAMIN	IEK

SUPERVISORY PATENT EXAMINER TECHNOLOGY CENTER 2800 Continuation of 11. does NOT place the application in condition for allowance because: The amended claims do not have any claim language changed which would make the claims allowable.

Applicant's arguments filed on 8/17/2006 have been fully considered.

Applicant states that Mishra fails to teach an array of corona producing elements, and to teach an array profile that reduces shielding effect. Mishra discloses a corona producing device (Figures 3, 4) comprising: a plurality of corona producing elements 114 arranged in an array; the elements being directed at and spaced from a charge retentive surface 20; the elements further being arranged in the array profile that reduces shielding effects; a power source (see Figure 3) connected to the at least one plurality of corona producing elements; and supports 116 to which the at least one plurality of corona producing elements are attached (Column 7, lines 46-58). Therefore, the reference teaches every element of Claim 1.

Applicant states that Walsh does not calculate the potential for an array of pins since Walsh only calculates the potential for a signle pin, and adjusting the array profile or the projection of the corona producing elements Walsh discloses a corona producing element profile determination method comprising determining an electrical potential in space between a charging device and a surface, determining a spatial variation of an electric field of the electric potential, determining the electric potential in space comprising determining an electrical potential at a plurality of points throughout a region between a charge-producing array of the corona producing elements and a photoreceptor of a marking machine to adjust an array profile of the corona producing elements (Page 104-108, Figures 10, 11). Laplace equations are set of general equations used for electric field calculations at any point in space. Walsh teaches the method, using the mathematical equations, of determining an electric potential in space, which is a point anywhere in space, including between a charging device and a surface, for functions including, to adjust an array profile of the corona producing elements, to reduce the shielding effect between various corona producing elements and therefore meets the claim limitations of independent claims 13 and 18.